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### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### Details

Product Status	Active
Number of LABs/CLBs	715
Number of Logic Elements/Cells	9152
Total RAM Bits	589824
Number of I/O	106
Number of Gates	-
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	196-TFBGA, CSBGA
Supplier Device Package	196-CSPBGA (8x8)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc6slx9-2cpg196c">https://www.e-xfl.com/product-detail/xilinx/xc6slx9-2cpg196c</a>

Table 1: Absolute Maximum Ratings<sup>(1)</sup> (Cont'd)

Symbol	Description			Units		
$V_{IN}$ and $V_{TS}^{(3)}$	I/O input voltage or voltage applied to 3-state output, relative to GND <sup>(4)</sup>	All user and dedicated I/Os	Commercial	DC	-0.60 to 4.10	V
				20% overshoot duration	-0.75 to 4.25	V
				8% overshoot duration <sup>(5)</sup>	-0.75 to 4.40	V
		Industrial	DC	DC	-0.60 to 3.95	V
				20% overshoot duration	-0.75 to 4.15	V
				4% overshoot duration <sup>(5)</sup>	-0.75 to 4.40	V
		Expanded (Q)	DC	DC	-0.60 to 3.95	V
				20% overshoot duration	-0.75 to 4.15	V
				4% overshoot duration <sup>(5)</sup>	-0.75 to 4.40	V
		Restricted to maximum of 100 user I/Os	Commercial	20% overshoot duration	-0.75 to 4.35	V
				15% overshoot duration <sup>(5)</sup>	-0.75 to 4.40	V
				10% overshoot duration	-0.75 to 4.45	V
		Industrial	20% overshoot duration	20% overshoot duration	-0.75 to 4.25	V
				10% overshoot duration	-0.75 to 4.35	V
				8% overshoot duration <sup>(5)</sup>	-0.75 to 4.40	V
		Expanded (Q)	20% overshoot duration	20% overshoot duration	-0.75 to 4.25	V
				10% overshoot duration	-0.75 to 4.35	V
				8% overshoot duration <sup>(5)</sup>	-0.75 to 4.40	V
$T_{STG}$	Storage temperature (ambient)			-65 to 150	°C	
$T_{SOL}$	Maximum soldering temperature <sup>(6)</sup> (TQG144, CPG196, CSG225, CSG324, CSG484, and FTG256)			+260	°C	
	Maximum soldering temperature <sup>(6)</sup> (Pb-free packages: FGG484, FGG676, and FGG900)			+250	°C	
	Maximum soldering temperature <sup>(6)</sup> (Pb packages: CS484, FT256, FG484, FG676, and FG900)			+220	°C	
$T_j$	Maximum junction temperature <sup>(6)</sup>			+125	°C	

**Notes:**

- Stresses beyond those listed under Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time might affect device reliability.
- When programming eFUSE,  $V_{FS} \leq V_{CCAUX}$ . Requires up to 40 mA current. For read mode,  $V_{FS}$  can be between GND and 3.45 V.
- I/O absolute maximum limit applied to DC and AC signals. Overshoot duration is the percentage of a data period that the I/O is stressed beyond 3.45V.
- For I/O operation, refer to [UG381: Spartan-6 FPGA SelectIO Resources User Guide](#).
- Maximum percent overshoot duration to meet 4.40V maximum.
- For soldering guidelines and thermal considerations, see [UG385: Spartan-6 FPGA Packaging and Pinout Specification](#).

Table 2: Recommended Operating Conditions<sup>(1)</sup>

Symbol	Description			Min	Typ	Max	Units
$V_{CCINT}$	Internal supply voltage relative to GND	-3, -3N, -2	Standard performance <sup>(2)</sup>	1.14	1.2	1.26	V
		-3, -2	Extended performance <sup>(2)</sup>	1.2	1.23	1.26	V
		-1L	Standard performance <sup>(2)</sup>	0.95	1.0	1.05	V
$V_{CCAUX}^{(3)(4)}$	Auxiliary supply voltage relative to GND	$V_{CCAUX} = 2.5V^{(5)}$		2.375	2.5	2.625	V
		$V_{CCAUX} = 3.3V$		3.15	3.3	3.45	V
$V_{CCO}^{(6)(7)(8)}$	Output supply voltage relative to GND			1.1	—	3.45	V
$V_{IN}$	Input voltage relative to GND	All I/O standards (except PCI)	Commercial temperature (C)	-0.5	—	4.0	V
			Industrial temperature (I)	-0.5	—	3.95	V
			Expanded (Q) temperature	-0.5	—	3.95	V
		PCI I/O standard <sup>(9)</sup>	—	-0.5	—	$V_{CCO} + 0.5$	V
$I_{IN}^{(10)}$	Maximum current through pin using PCI I/O standard when forward biasing the clamp diode. <sup>(9)</sup>	Commercial (C) and Industrial temperature (I)		—	—	10	mA
		Expanded (Q) temperature		—	—	7	mA
$V_{BATT}^{(11)}$	Battery voltage relative to GND, $T_j = 0^\circ\text{C}$ to $+85^\circ\text{C}$ (LX75, LX75T, LX100, LX100T, LX150, and LX150T only)			1.0	—	3.6	V
$T_j$	Junction temperature operating range	Commercial (C) range		0	—	85	$^\circ\text{C}$
		Industrial temperature (I) range		-40	—	100	$^\circ\text{C}$
		Expanded (Q) temperature range		-40	—	125	$^\circ\text{C}$

**Notes:**

1. All voltages are relative to ground.
2. See *Interface Performances for Memory Interfaces* in Table 25. The extended performance range is specified for designs not using the standard  $V_{CCINT}$  voltage range. The standard  $V_{CCINT}$  voltage range is used for:
  - Designs that do not use an MCB
  - LX4 devices
  - Devices in the TQG144 or CPG196 packages
  - Devices with the -3N speed grade
3. Recommended maximum voltage droop for  $V_{CCAUX}$  is 10 mV/ms.
4. During configuration, if  $V_{CCO\_2}$  is 1.8V, then  $V_{CCAUX}$  must be 2.5V.
5. The -1L devices require  $V_{CCAUX} = 2.5V$  when using the LVDS\_25, LVDS\_33, BLVDS\_25, LVPECL\_25, RSDS\_25, RSDS\_33, PPDS\_25, and PPDS\_33 I/O standards on inputs. LVPECL\_33 is not supported in the -1L devices.
6. Configuration data is retained even if  $V_{CCO}$  drops to 0V.
7. Includes  $V_{CCO}$  of 1.2V, 1.5V, 1.8V, 2.5V, and 3.3V.
8. For PCI systems, the transmitter and receiver should have common supplies for  $V_{CCO}$ .
9. Devices with a -1L speed grade do not support Xilinx PCI IP.
10. Do not exceed a total of 100 mA per bank.
11.  $V_{BATT}$  is required to maintain the battery backed RAM (BBR) AES key when  $V_{CCAUX}$  is not applied. Once  $V_{CCAUX}$  is applied,  $V_{BATT}$  can be unconnected. When BBR is not used, Xilinx recommends connecting to  $V_{CCAUX}$  or GND. However,  $V_{BATT}$  can be unconnected.

Table 3: eFUSE Programming Conditions<sup>(1)</sup>

Symbol	Description	Min	Typ	Max	Units
$V_{FS}$ <sup>(2)</sup>	External voltage supply	3.2	3.3	3.4	V
$I_{FS}$	$V_{FS}$ supply current	–	–	40	mA
$V_{CCAUX}$	Auxiliary supply voltage relative to GND	3.2	3.3	3.45	V
$R_{FUSE}$ <sup>(3)</sup>	External resistor from $R_{FUSE}$ pin to GND	1129	1140	1151	$\Omega$
$V_{CCINT}$	Internal supply voltage relative to GND	1.14	1.2	1.26	V
$t_j$	Temperature range	15	–	85	$^{\circ}\text{C}$

**Notes:**

1. These specifications apply during programming of the eFUSE AES key. Programming is only supported through JTAG. The AES key is only supported in the following devices: LX75, LX75T, LX100, LX100T, LX150, and LX150T.
2. When programming eFUSE,  $V_{FS}$  must be less than or equal to  $V_{CCAUX}$ . When not programming or when eFUSE is not used, Xilinx recommends connecting  $V_{FS}$  to GND. However,  $V_{FS}$  can be between GND and 3.45 V.
3. An  $R_{FUSE}$  resistor is required when programming the eFUSE AES key. When not programming or when eFUSE is not used, Xilinx recommends connecting the  $R_{FUSE}$  pin to  $V_{CCAUX}$  or GND. However,  $R_{FUSE}$  can be unconnected.

Table 4: DC Characteristics Over Recommended Operating Conditions

Symbol	Description	Min	Typ	Max	Units
$V_{DRINT}$	Data retention $V_{CCINT}$ voltage (below which configuration data might be lost)	0.8	—	—	V
$V_{DRAUX}$	Data retention $V_{CCAUX}$ voltage (below which configuration data might be lost)	2.0	—	—	V
$I_{REF}$	$V_{REF}$ leakage current per pin for commercial (C) and industrial (I) devices	-10	—	10	$\mu A$
	$V_{REF}$ leakage current per pin for expanded (Q) devices	-15	—	15	$\mu A$
$I_L$	Input or output leakage current per pin (sample-tested) for commercial (C) and industrial (I) devices	-10	—	10	$\mu A$
	Input or output leakage current per pin (sample-tested) for expanded (Q) devices	-15	—	15	$\mu A$
$I_{HS}$	Leakage current on pins during hot socketing with FPGA unpowered	All pins except PROGRAM_B, DONE, and JTAG pins when HSWAPEN = 1	-20	—	20 $\mu A$
		PROGRAM_B, DONE, and JTAG pins, or other pins when HSWAPEN = 0	$I_{HS} + I_{RPU}$		$\mu A$
$C_{IN}^{(1)}$	Die input capacitance at the pad	—	—	10	pF
$I_{RPU}$	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 3.3V$ or $V_{CCAUX} = 3.3V$	200	—	500	$\mu A$
	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 2.5V$ or $V_{CCAUX} = 2.5V$	120	—	350	$\mu A$
	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 1.8V$	60	—	200	$\mu A$
	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 1.5V$	40	—	150	$\mu A$
	Pad pull-up (when selected) @ $V_{IN} = 0V$ , $V_{CCO} = 1.2V$	12	—	100	$\mu A$
$I_{RPD}$	Pad pull-down (when selected) @ $V_{IN} = V_{CCO}$ , $V_{CCAUX} = 3.3V$	200	—	550	$\mu A$
	Pad pull-down (when selected) @ $V_{IN} = V_{CCO}$ , $V_{CCAUX} = 2.5V$	140	—	400	$\mu A$
$I_{BATT}^{(2)}$	Battery supply current	—	—	150	nA
$R_{DT}^{(3)}$	Resistance of optional input differential termination circuit, $V_{CCAUX} = 3.3V$	—	100	—	$\Omega$
$R_{IN\_TERM}^{(5)}$	Thevenin equivalent resistance of programmable input termination to $V_{CCO}$ (UNTUNED_SPLIT_25) for commercial (C) and industrial (I) devices	23	25	55	$\Omega$
	Thevenin equivalent resistance of programmable input termination to $V_{CCO}$ (UNTUNED_SPLIT_25) for expanded (Q) devices	20	25	55	$\Omega$
	Thevenin equivalent resistance of programmable input termination to $V_{CCO}$ (UNTUNED_SPLIT_50) for commercial (C) and industrial (I) devices	39	50	72	$\Omega$
	Thevenin equivalent resistance of programmable input termination to $V_{CCO}$ (UNTUNED_SPLIT_50) for expanded (Q) devices	32	50	74	$\Omega$
	Thevenin equivalent resistance of programmable input termination to $V_{CCO}$ (UNTUNED_SPLIT_75) for commercial (C) and industrial (I) devices	56	75	109	$\Omega$
	Thevenin equivalent resistance of programmable input termination to $V_{CCO}$ (UNTUNED_SPLIT_75) for expanded (Q) devices	47	75	115	$\Omega$
$R_{OUT\_TERM}$	Thevenin equivalent resistance of programmable output termination (UNTUNED_25)	11	25	52	$\Omega$
	Thevenin equivalent resistance of programmable output termination (UNTUNED_50)	21	50	96	$\Omega$
	Thevenin equivalent resistance of programmable output termination (UNTUNED_75)	29	75	145	$\Omega$

**Notes:**

1. The  $C_{IN}$  measurement represents the die capacitance at the pad, not including the package.
2. Maximum value specified for worst case process at 25°C. LX75, LX75T, LX100, LX100T, LX150, and LX150T only.
3. Refer to IBIS models for  $R_{DT}$  variation and for values at  $V_{CCAUX} = 2.5V$ . IBIS values for  $R_{DT}$  are valid for all temperature ranges.
4.  $V_{CCO2}$  is not required for data retention. The minimum  $V_{CCO2}$  for power-on reset and configuration is 1.65V.
5. Termination resistance to a  $V_{CCO}/2$  level.

## Production Silicon and ISE Software Status

In some cases, a particular family member (and speed grade) is released to production before a speed specification is released with the correct label (Advance, Preliminary, Production). Any labeling discrepancies are corrected in subsequent speed specification releases. [Table 27](#) lists the production released Spartan-6 family member, speed grade, and the minimum corresponding supported speed specification version and ISE® software revisions. The ISE software and speed specifications listed are the minimum releases required for production. All subsequent releases of software and speed specifications are valid.

**Table 27: Spartan-6 Device Production Software and Speed Specification Release<sup>(1)</sup>**

Device	Speed Grade Designations <sup>(2)</sup>			
	-3 <sup>(3)</sup>	-3N	-2 <sup>(4)</sup>	-1L
XC6SLX4	ISE 12.4 v1.15	N/A	ISE 12.3 v1.12 <sup>(5)</sup>	ISE 13.2 v1.07
XC6SLX9	ISE 12.4 v1.15	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.3 v1.12 <sup>(5)</sup>	ISE 13.2 v1.07
XC6SLX16	ISE 12.1 v1.08	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 11.5 v1.06	ISE 13.2 v1.07
XC6SLX25	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.2 v1.07
XC6SLX25T	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	N/A
XC6SLX45	ISE 12.1 v1.08	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 11.5 v1.07	ISE 13.1 v1.06
XC6SLX45T	ISE 12.1 v1.08	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.1 v1.08	N/A
XC6SLX75	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.2 v1.07
XC6SLX75T	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	N/A
XC6SLX100	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 v1.06
XC6SLX100T	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	N/A
XC6SLX150	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 v1.06
XC6SLX150T	ISE 12.2 v1.11 <sup>(6)</sup>	ISE 13.1 Update v1.18 <sup>(7)</sup>	ISE 12.2 v1.11 <sup>(6)</sup>	N/A
XA6SLX4	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX9	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX16	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX25	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX25T	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX45	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX45T	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX75	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX75T	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XA6SLX100	N/A	N/A	ISE 13.3 v1.20	N/A

Table 27: Spartan-6 Device Production Software and Speed Specification Release<sup>(1)</sup> (Cont'd)

Device	Speed Grade Designations <sup>(2)</sup>			
	-3 <sup>(3)</sup>	-3N	-2 <sup>(4)</sup>	-1L
XQ6SLX75	N/A	N/A	ISE 13.2 v1.19	ISE 13.2 v1.07
XQ6SLX75T	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A
XQ6SLX150	N/A	N/A	ISE 13.2 v1.19	ISE 13.2 v1.07
XQ6SLX150T	ISE 13.2 v1.19	N/A	ISE 13.2 v1.19	N/A

**Notes:**

1. ISE 13.3 software with v1.20 for -3, -3N, and -2; and v1.08 for -1L speed specification reflects the changes outlined in [XCN11028: Spartan-6 FPGA Speed File Changes](#).
2. As marked with an N/A, LXT devices and all XA devices are not available with a -1L speed grade; LX4 devices and all XA and XQ devices are not available with a -3N speed grade.
3. Improved -3 specifications reflected in this data sheet require ISE 12.4 software with v1.15 speed specification.
4. Improved -2 specifications reflected in this data sheet require ISE 12.4 software and the *12.4 Speed Files Patch* which contains the v1.17 speed specification available on the [Xilinx Download Center](#).
5. ISE 12.3 software with v1.12 speed specification is available using ISE 12.3 software and the *12.3 Speed Files Patch* available on the [Xilinx Download Center](#).
6. ISE 12.2 software with v1.11 speed specification is available using ISE 12.2 software and the *12.2 Speed Files Patch* available on the [Xilinx Download Center](#).
7. ISE 13.1 software with v1.18 speed specification is available using ISE 13.1 software and the *13.1 Update* available on the [Xilinx Download Center](#). See [XCN11012: Speed File Change for -3N Devices](#).

**IOB Pad Input/Output/3-State Switching Characteristics**

**Table 28** (for commercial (XC) Spartan-6 devices) and **Table 29** (for Automotive XA Spartan-6 and Defense-grade Spartan-6Q devices) summarizes the values of standard-specific data input delays, output delays terminating at pads (based on standard), and 3-state delays.

- $T_{IOPI}$  is described as the delay from IOB pad through the input buffer to the I-pin of an IOB pad. The delay varies depending on the capability of the SelectIO input buffer.
- $T_{IOOP}$  is described as the delay from the O pin to the IOB pad through the output buffer of an IOB pad. The delay varies depending on the capability of the SelectIO output buffer.
- $T_{IOTP}$  is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is disabled. The delay varies depending on the SelectIO capability of the output buffer.

See the TRACE report for further information on delays when using an I/O standard with UNTUNED termination on inputs or outputs.

Table 28: IOB Switching Characteristics for the Commercial (XC) Spartan-6 Devices

I/O Standard	$T_{IOPI}$				$T_{IOOP}$				$T_{IOTP}$				Units	
	Speed Grade				Speed Grade				Speed Grade					
	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>		
LVDS_33	1.17	1.29	1.42	1.68	1.55	1.69	1.89	2.42	3000	3000	3000	3000	ns	
LVDS_25	1.01	1.13	1.26	1.57	1.65	1.79	1.99	2.47	3000	3000	3000	3000	ns	
BLVDS_25	1.02	1.14	1.27	1.57	1.72	1.86	2.06	2.68	1.72	1.86	2.06	2.68	ns	
MINI_LVDS_33	1.17	1.29	1.42	1.68	1.57	1.71	1.91	2.41	3000	3000	3000	3000	ns	
MINI_LVDS_25	1.01	1.13	1.26	1.57	1.65	1.79	1.99	2.47	3000	3000	3000	3000	ns	
LVPECL_33	1.18	1.30	1.43	1.68	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	ns	
LVPECL_25	1.02	1.14	1.27	1.57	N/A	N/A	N/A	N/A	N/A	N/A	N/A	N/A	ns	
RSDS_33 (point to point)	1.17	1.29	1.42	1.68	1.57	1.71	1.91	2.42	3000	3000	3000	3000	ns	
RSDS_25 (point to point)	1.01	1.13	1.26	1.56	1.65	1.79	1.99	2.47	3000	3000	3000	3000	ns	
TMDS_33	1.21	1.33	1.46	1.71	1.54	1.68	1.88	2.50	3000	3000	3000	3000	ns	

Table 28: IOB Switching Characteristics for the Commercial (XC) Spartan-6 Devices (Cont'd)

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>	-3	-3N	-2	-1L <sup>(1)</sup>		
PPDS_33	1.17	1.29	1.42	1.68	1.57	1.71	1.91	2.43	3000	3000	3000	3000	ns	
PPDS_25	1.01	1.13	1.26	1.56	1.68	1.82	2.02	2.47	3000	3000	3000	3000	ns	
PCI33_3	1.07	1.19	1.32	1.57 <sup>(2)</sup>	3.51	3.65	3.85	4.38 <sup>(2)</sup>	3.51	3.65	3.85	4.38 <sup>(1)</sup>	ns	
PCI66_3	1.07	1.19	1.32	1.57 <sup>(2)</sup>	3.53	3.67	3.87	4.39 <sup>(2)</sup>	3.53	3.67	3.87	4.39 <sup>(1)</sup>	ns	
DISPLAY_PORT	1.02	1.14	1.27	1.56	3.15	3.29	3.49	4.08	3.15	3.29	3.49	4.08	ns	
I2C	1.33	1.45	1.58	1.82	11.56	11.70	11.90	12.52	11.56	11.70	11.90	12.52	ns	
SMBUS	1.33	1.45	1.58	1.82	11.56	11.70	11.90	12.52	11.56	11.70	11.90	12.52	ns	
SDIO	1.36	1.48	1.61	1.84	2.64	2.78	2.98	3.60	2.64	2.78	2.98	3.60	ns	
MOBILE_DDR	0.94	1.06	1.19	1.43	2.35	2.49	2.69	3.31	2.35	2.49	2.69	3.31	ns	
HSTL_I	0.90	1.02	1.15	1.39	1.66	1.80	2.00	2.62	1.66	1.80	2.00	2.62	ns	
HSTL_II	0.91	1.03	1.16	1.40	1.72	1.86	2.06	2.68	1.72	1.86	2.06	2.68	ns	
HSTL_III	0.95	1.07	1.20	1.44	1.67	1.81	2.01	2.61	1.67	1.81	2.01	2.61	ns	
HSTL_I_18	0.94	1.06	1.19	1.43	1.77	1.91	2.11	2.73	1.77	1.91	2.11	2.73	ns	
HSTL_II_18	0.94	1.06	1.19	1.43	1.85	1.99	2.19	2.81	1.85	1.99	2.19	2.81	ns	
HSTL_III_18	0.99	1.11	1.24	1.47	1.79	1.93	2.13	2.72	1.79	1.93	2.13	2.72	ns	
SSTL3_I	1.58	1.70	1.83	2.16	1.83	1.97	2.17	2.72	1.83	1.97	2.17	2.72	ns	
SSTL3_II	1.58	1.70	1.83	2.16	2.01	2.15	2.35	2.94	2.01	2.15	2.35	2.94	ns	
SSTL2_I	1.30	1.42	1.55	1.87	1.77	1.91	2.11	2.69	1.77	1.91	2.11	2.69	ns	
SSTL2_II	1.30	1.42	1.55	1.88	1.86	2.00	2.20	2.82	1.86	2.00	2.20	2.82	ns	
SSTL18_I	0.92	1.04	1.17	1.41	1.63	1.77	1.97	2.59	1.63	1.77	1.97	2.59	ns	
SSTL18_II	0.92	1.04	1.17	1.41	1.66	1.80	2.00	2.62	1.66	1.80	2.00	2.62	ns	
SSTL15_II	0.92	1.04	1.17	1.41	1.67	1.81	2.01	2.63	1.67	1.81	2.01	2.63	ns	
DIFF_HSTL_I	0.94	1.06	1.19	1.46	1.77	1.91	2.11	2.62	1.77	1.91	2.11	2.62	ns	
DIFF_HSTL_II	0.93	1.05	1.18	1.45	1.72	1.86	2.06	2.54	1.72	1.86	2.06	2.54	ns	
DIFF_HSTL_III	0.93	1.05	1.18	1.46	1.69	1.83	2.03	2.53	1.69	1.83	2.03	2.53	ns	
DIFF_HSTL_I_18	0.97	1.09	1.22	1.50	1.79	1.93	2.13	2.63	1.79	1.93	2.13	2.63	ns	
DIFF_HSTL_II_18	0.97	1.09	1.22	1.49	1.69	1.83	2.03	2.51	1.69	1.83	2.03	2.51	ns	
DIFF_HSTL_III_18	0.97	1.09	1.22	1.50	1.69	1.83	2.03	2.53	1.69	1.83	2.03	2.53	ns	
DIFF_SSTL3_I	1.18	1.30	1.43	1.68	1.81	1.95	2.15	2.64	1.81	1.95	2.15	2.64	ns	
DIFF_SSTL3_II	1.19	1.31	1.44	1.68	1.80	1.94	2.14	2.63	1.80	1.94	2.14	2.63	ns	
DIFF_SSTL2_I	1.02	1.14	1.27	1.57	1.80	1.94	2.14	2.62	1.80	1.94	2.14	2.62	ns	
DIFF_SSTL2_II	1.02	1.14	1.27	1.57	1.76	1.90	2.10	2.57	1.76	1.90	2.10	2.57	ns	
DIFF_SSTL18_I	0.97	1.09	1.22	1.51	1.72	1.86	2.06	2.56	1.72	1.86	2.06	2.56	ns	
DIFF_SSTL18_II	0.98	1.10	1.23	1.50	1.68	1.82	2.02	2.52	1.68	1.82	2.02	2.52	ns	
DIFF_SSTL15_II	0.94	1.06	1.19	1.46	1.67	1.81	2.01	2.50	1.67	1.81	2.01	2.50	ns	
DIFF_MOBILE_DDR	0.97	1.09	1.22	1.51	1.75	1.89	2.09	2.57	1.75	1.89	2.09	2.57	ns	

Table 29: IOB Switching Characteristics for the Automotive XA Spartan-6 and the Spartan-6Q Devices<sup>(1)</sup> (Cont'd)

I/O Standard	$T_{IOPI}$		$T_{IOOP}$		$T_{IOTP}$		Units	
	Speed Grade		Speed Grade		Speed Grade			
	-3	-2	-3	-2	-3	-2		
LVCMOS12, QUIETIO, 6 mA	0.98	1.16	4.79	4.99	4.79	4.99	ns	
LVCMOS12, QUIETIO, 8 mA	0.98	1.16	4.43	4.63	4.43	4.63	ns	
LVCMOS12, QUIETIO, 12 mA	0.98	1.16	4.18	4.38	4.18	4.38	ns	
LVCMOS12, Slow, 2 mA	0.98	1.16	5.12	5.32	5.12	5.32	ns	
LVCMOS12, Slow, 4 mA	0.98	1.16	3.00	3.20	3.00	3.20	ns	
LVCMOS12, Slow, 6 mA	0.98	1.16	2.91	3.11	2.91	3.11	ns	
LVCMOS12, Slow, 8 mA	0.98	1.16	2.51	2.71	2.51	2.71	ns	
LVCMOS12, Slow, 12 mA	0.98	1.16	2.25	2.45	2.25	2.45	ns	
LVCMOS12, Fast, 2 mA	0.98	1.16	3.60	3.80	3.60	3.80	ns	
LVCMOS12, Fast, 4 mA	0.98	1.16	2.49	2.69	2.49	2.69	ns	
LVCMOS12, Fast, 6 mA	0.98	1.16	1.94	2.14	1.94	2.14	ns	
LVCMOS12, Fast, 8 mA	0.98	1.16	1.82	2.02	1.82	2.02	ns	
LVCMOS12, Fast, 12 mA	0.98	1.16	1.80	2.00	1.80	2.00	ns	
LVCMOS12_JEDEC, QUIETIO, 2 mA	1.57	1.75	6.53	6.73	6.53	6.73	ns	
LVCMOS12_JEDEC, QUIETIO, 4 mA	1.57	1.75	5.12	5.32	5.12	5.32	ns	
LVCMOS12_JEDEC, QUIETIO, 6 mA	1.57	1.75	4.81	5.01	4.81	5.01	ns	
LVCMOS12_JEDEC, QUIETIO, 8 mA	1.57	1.75	4.44	4.64	4.44	4.64	ns	
LVCMOS12_JEDEC, QUIETIO, 12 mA	1.57	1.75	4.20	4.40	4.20	4.40	ns	
LVCMOS12_JEDEC, Slow, 2 mA	1.57	1.75	5.14	5.34	5.14	5.34	ns	
LVCMOS12_JEDEC, Slow, 4 mA	1.57	1.75	2.99	3.19	2.99	3.19	ns	
LVCMOS12_JEDEC, Slow, 6 mA	1.57	1.75	2.90	3.10	2.90	3.10	ns	
LVCMOS12_JEDEC, Slow, 8 mA	1.57	1.75	2.50	2.70	2.50	2.70	ns	
LVCMOS12_JEDEC, Slow, 12 mA	1.57	1.75	2.26	2.46	2.26	2.46	ns	
LVCMOS12_JEDEC, Fast, 2 mA	1.57	1.75	3.60	3.80	3.60	3.80	ns	
LVCMOS12_JEDEC, Fast, 4 mA	1.57	1.75	2.49	2.69	2.49	2.69	ns	
LVCMOS12_JEDEC, Fast, 6 mA	1.57	1.75	1.94	2.14	1.94	2.14	ns	
LVCMOS12_JEDEC, Fast, 8 mA	1.57	1.75	1.83	2.03	1.83	2.03	ns	
LVCMOS12_JEDEC, Fast, 12 mA	1.57	1.75	1.80	2.00	1.80	2.00	ns	

**Notes:**

1. The Spartan-6Q FPGA -1L values are listed in Table 28.

Table 30 summarizes the value of  $T_{IOTPHZ}$ .  $T_{IOTPHZ}$  is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is enabled (i.e., a high impedance state). These delays are measured using LVCMOS25, Fast, 12 mA.

Table 30: IOB 3-state ON Output Switching Characteristics ( $T_{IOTPHZ}$ )

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
$T_{IOTPHZ}$	T input to Pad high-impedance	1.39	1.59	1.59	1.91	ns

Table 33: Spartan-6 FPGA V<sub>CCO</sub>/GND Pairs per Bank

Package	Devices	Description	Bank 0	Bank 1	Bank 2	Bank 3	Bank 4	Bank 5
TQG144	LX	V <sub>CCO</sub> /GND Pairs	3	3	2	3	N/A	N/A
		Maximum I/O per Pair	8	8	13	8	N/A	N/A
CPG196	LX	V <sub>CCO</sub> /GND Pairs	4	6	4	6	N/A	N/A
		Maximum I/O per Pair	6	4	7	4	N/A	N/A
CSG225	LX	V <sub>CCO</sub> /GND Pairs	4	4	4	4	N/A	N/A
		Maximum I/O per Pair	10	10	9	10	N/A	N/A
FT(G)256	LX	V <sub>CCO</sub> /GND Pairs	5	6	4	5	N/A	N/A
		Maximum I/O per Pair	8	9	9	10	N/A	N/A
CSG324	LX	V <sub>CCO</sub> /GND Pairs	6	6	6	6	N/A	N/A
		Maximum I/O per Pair	10	9	10	9	N/A	N/A
	LXT	V <sub>CCO</sub> /GND Pairs	4	6	6	6	N/A	N/A
		Maximum I/O per Pair	4	9	10	9	N/A	N/A
CS(G)484	LX	V <sub>CCO</sub> /GND Pairs	8	13	8	13	N/A	N/A
		Maximum I/O per Pair	7	8	7	8	N/A	N/A
	LXT	V <sub>CCO</sub> /GND Pairs	7	12	8	13	N/A	N/A
		Maximum I/O per Pair	5	8	6	8	N/A	N/A
FG(G)484	LX	V <sub>CCO</sub> /GND Pairs	10	10	11	11	N/A	N/A
		Maximum I/O per Pair	6	8	9	8	N/A	N/A
	LXT	V <sub>CCO</sub> /GND Pairs	6	10	11	10	N/A	N/A
		Maximum I/O per Pair	7	8	7	8	N/A	N/A
FG(G)676	LX45	V <sub>CCO</sub> /GND Pairs	12	15	10	16	N/A	N/A
		Maximum I/O per Pair	3	7	8	7	N/A	N/A
	LX75, LX100, LX150	V <sub>CCO</sub> /GND Pairs	12	9	10	10	6	6
		Maximum I/O per Pair	9	10	9	9	8	9
FG(G)900	LXT	V <sub>CCO</sub> /GND Pairs	10	8	10	8	7	7
		Maximum I/O per Pair	8	7	8	8	7	7
	LX	V <sub>CCO</sub> /GND Pairs	17	14	17	14	7	8
		Maximum I/O per Pair	7	6	7	8	7	6
	LXT	V <sub>CCO</sub> /GND Pairs	15	14	13	14	7	8
		Maximum I/O per Pair	7	6	8	8	7	6

Table 34: SSO Limit per V<sub>CCO</sub>/GND Pair (Cont'd)

V <sub>CCO</sub>	I/O Standard	Drive	Slew	SSO Limit per V <sub>CCO</sub> /GND Pair					
				All TQG144, CPG196, CSG225, FT(G)256, and LX devices in CSG324		All CS(G)484, FG(G)484, FG(G)676, FG(G)900, and LXT devices in CSG324			
				Bank 0/2	Bank 1/3	Bank 0/2	Bank 1/3/4/5		
1.5V	LVCMOS15, LVCMOS15_JEDEC	2	Fast	33	40	33	41		
			Slow	57	62	57	56		
			QuietIO	70	67	70	66		
		4	Fast	19	21	19	21		
			Slow	30	30	30	24		
			QuietIO	38	33	38	30		
		6	Fast	14	16	14	16		
			Slow	18	19	18	17		
			QuietIO	27	24	27	21		
		8	Fast	11	13	11	12		
			Slow	16	16	16	14		
			QuietIO	23	20	23	17		
		12	Fast	N/A	5	N/A	4		
			Slow	N/A	8	N/A	5		
			QuietIO	N/A	10	N/A	9		
		16	Fast	N/A	5	N/A	4		
			Slow	N/A	8	N/A	8		
			QuietIO	N/A	10	N/A	9		
HSTL_I				9	10	9	10		
HSTL_II				N/A	5	N/A	6		
HSTL_III				7	9	7	9		
DIFF_HSTL_I				27	30	27	30		
DIFF_HSTL_II				N/A	15	N/A	18		
DIFF_HSTL_III				21	27	21	27		
SSTL_15_II <sup>(3)</sup>				N/A	5	N/A	4		
DIFF_SSTL_15_II <sup>(3)</sup>				N/A	15	N/A	12		

## Block RAM Switching Characteristics

Table 43: Block RAM Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3	-3N	-2	-1L	
<b>Block RAM Clock to Out Delays</b>						
T <sub>RCKO_DO</sub>	Clock CLK to DOUT output (without output register) <sup>(1)</sup>	1.85	2.10	2.10	3.50	ns, Max
T <sub>RCKO_DO_REG</sub>	Clock CLK to DOUT output (with output register) <sup>(2)</sup>	1.60	1.75	1.75	2.30	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>						
T <sub>RCKC_ADDR</sub> /T <sub>RCKC_ADDR</sub>	ADDR inputs for XC devices <sup>(3)</sup>	0.35/ 0.10	0.40/ 0.12	0.40/ 0.12	0.50/ 0.15	ns, Min
	ADDR inputs for XA and XQ devices <sup>(3)</sup>	0.35/ 0.17	N/A	0.40/ 0.17	0.50/ 0.15	ns, Min
T <sub>RDCK_DI</sub> /T <sub>RCKD_DI</sub>	DIN inputs <sup>(4)</sup>	0.30/ 0.10	0.30/ 0.10	0.30/ 0.10	0.40/ 0.15	ns, Min
T <sub>RCKC_EN</sub> /T <sub>RCKC_EN</sub>	Block RAM Enable (EN) input	0.22/ 0.05	0.25/ 0.06	0.25/ 0.06	0.44/ 0.10	ns, Min
T <sub>RCKC_REGCE</sub> /T <sub>RCKC_REGCE</sub>	CE input of output register	0.20/ 0.10	0.20/ 0.10	0.20/ 0.10	0.28/ 0.15	ns, Min
T <sub>RCKC_WE</sub> /T <sub>RCKC_WE</sub>	Write Enable (WE) input	0.25/ 0.10	0.33/ 0.10	0.33/ 0.10	0.28/ 0.15	ns, Min
<b>Maximum Frequency</b>						
F <sub>MAX</sub>	Block RAM in all modes	320	280	280	150	MHz

**Notes:**

1. T<sub>RCKO\_DO</sub> includes T<sub>RCKO\_DOA</sub> and T<sub>RCKO\_DOPA</sub> as well as the B port equivalent timing parameters.
2. T<sub>RCKO\_DO\_REG</sub> includes T<sub>RCKO\_DOA\_REG</sub> and T<sub>RCKO\_DOPA\_REG</sub> as well as the B port equivalent timing parameters.
3. The ADDR setup and hold must be met when EN is asserted (even when WE is deasserted). Otherwise, block RAM data corruption is possible.
4. T<sub>RDCK\_DI</sub> includes both A and B inputs as well as the parity inputs of A and B.

Table 44: DSP48A1 Switching Characteristics (Cont'd)

Symbol	Description	Pre-adder	Multiplier	Post-adder	Speed Grade				Units
					-3	-3N	-2	-1L	
$T_{DSPDCK\_OPMODE\_PREG}$ / $T_{DSPCKD\_OPMODE\_PREG}$	OPMODE input to P register CLK	Yes	Yes	Yes	6.21/ -0.84	7.27/ -0.84	7.27/ -0.84	10.43/ -0.84	ns
		No	Yes	Yes	1.69/ -0.87	1.98/ -0.87	1.98/ -0.87	3.62/ -0.87	ns
		No	No	Yes	2.09/ -0.22	2.30/ -0.22	2.30/ -0.22	3.79/ -0.22	ns
<b>Clock to Out from Output Register Clock to Output Pin</b>									
$T_{DSPCKO\_P\_PREG}$	CLK (PREG) to P output	N/A	N/A	N/A	1.20	1.34	1.34	1.90	ns
<b>Clock to Out from Pipeline Register Clock to Output Pins</b>									
$T_{DSPCKO\_P\_MREG}$	CLK (MREG) to P output	N/A	N/A	Yes	3.38	3.95	3.95	5.83	ns
<b>Clock to Out from Input Register Clock to Output Pins</b>									
$T_{DSPCKO\_P\_A1REG}$	CLK (A1REG) to P output	N/A	Yes	Yes	5.02	5.87	5.87	9.65	ns
$T_{DSPCKO\_P\_B1REG}$	CLK (B1REG) to P output	N/A	Yes	Yes	5.02	5.87	5.87	9.63	ns
$T_{DSPCKO\_P\_CREG}$	CLK (CREG) to P output	N/A	N/A	Yes	3.12	3.64	3.64	5.24	ns
$T_{DSPCKO\_P\_DREG}$	CLK (DREG) to P output	Yes	Yes	Yes	6.77	7.92	7.92	12.53	ns
<b>Combinatorial Delays from Input Pins to Output Pins</b>									
$T_{DSPDO\_A\_P}$	A input to P output	N/A	No	Yes	2.85	3.33	3.33	4.73	ns
		N/A	Yes	No <sup>(2)</sup>	3.35	3.93	3.93	6.74	ns
		N/A	Yes	Yes	4.56	5.22	5.22	8.94	ns
$T_{DSPDO\_B\_P}$	B input to P output	Yes	No	No <sup>(2)</sup>	3.22	3.76	3.76	5.55	ns
		Yes	Yes	No <sup>(2)</sup>	6.01	6.54	6.54	9.76	ns
		Yes	Yes	Yes	6.27	7.34	7.34	11.96	ns
$T_{DSPDO\_C\_P}$	C input to P output	N/A	N/A	Yes	2.69	3.15	3.15	4.68	ns
$T_{DSPDO\_D\_P}$	D input to P output	Yes	Yes	Yes	6.31	7.38	7.38	11.81	ns
$T_{DSPDO\_OPMODE\_P}$	OPMODE input to P output	Yes	Yes	Yes	6.43	7.52	7.52	11.84	ns
		No	Yes	Yes	4.84	5.66	5.66	9.25	ns
		No	No	Yes	3.11	3.49	3.49	5.03	ns
<b>Maximum Frequency</b>									
$F_{MAX}$	All registers used	Yes	Yes	Yes	390	333	333	213	MHz

**Notes:**

1. A Yes signifies that the component is in the path. A No signifies that the component is being bypassed. N/A signifies not applicable because no path exists.
2. Implemented in the post-adder by adding to zero.

Table 54: Switching Characteristics for the Delay-Locked Loop (DLL)<sup>(1)</sup> (Cont'd)

Symbol	Description	Speed Grade								Units	
		-3		-3N		-2		-1L			
		Min	Max	Min	Max	Min	Max	Min	Max		
LOCK_DLL <sup>(3)</sup>	When using the DLL alone: The time from deassertion at the DCM's reset input to the rising transition at its LOCKED output. When the DCM is locked, the CLKIN and CLKFB signals are in phase. CLKIN_FREQ_DLL < 50 MHz.	—	5	—	5	—	5	—	5	ms	
	When using the DLL alone: The time from deassertion at the DCM's reset input to the rising transition at its LOCKED output. When the DCM is locked, the CLKIN and CLKFB signals are in phase. CLKIN_FREQ_DLL > 50 MHz.	—	0.60	—	0.60	—	0.60	—	0.60	ms	
<b>Delay Lines</b>											
DCM_DELAY_STEP <sup>(5)</sup>	Finest delay resolution, averaged over all steps.	10	40	10	40	10	40	10	40	ps	

**Notes:**

- The values in this table are based on the operating conditions described in Table 2 and Table 53.
- Indicates the maximum amount of output jitter that the DCM adds to the jitter on the CLKIN input.
- For optimal jitter tolerance and faster LOCK time, use the CLKIN\_PERIOD attribute.
- Some jitter and duty-cycle specifications include 1% of input clock period or 0.01 UI. For example, this data sheet specifies a maximum jitter of  $\pm(1\% \text{ of CLKIN period} + 150 \text{ ps})$ . Assuming that the CLKIN frequency is 100 MHz, the equivalent CLKIN period is 10 ns. Since 1% of 10 ns is 0.1 ns or 100 ps, the maximum jitter is  $\pm(100 \text{ ps} + 150 \text{ ps}) = \pm250 \text{ ps}$ .
- A typical delay step size is 23 ps.
- The timing analysis tools use the CLK\_FEEDBACK = 1X condition for the CLKIN\_CLKFB\_PHASE value (reported as phase error). When using CLK\_FEEDBACK = 2X, add 100 ps to the phase error for the CLKIN\_CLKFB\_PHASE value (as shown in this table).

Table 55: Recommended Operating Conditions for the Digital Frequency Synthesizer (DFS)<sup>(1)</sup>

Symbol	Description	Speed Grade								Units	
		-3		-3N		-2		-1L			
		Min	Max	Min	Max	Min	Max	Min	Max		
<b>Input Frequency Ranges<sup>(2)</sup></b>											
CLKIN_FREQ_FX	Frequency for the CLKIN input. Also described as F <sub>CLKIN</sub> .	0.5	375 <sup>(3)</sup>	0.5	375 <sup>(3)</sup>	0.5	333 <sup>(3)</sup>	0.5	200 <sup>(3)</sup>	MHz	
<b>Input Clock Jitter Tolerance<sup>(4)</sup></b>											
CLKIN_CYC_JITT_FX_LF	Cycle-to-cycle jitter at the CLKIN input, based on CLKFX output frequency: F <sub>CLKFX</sub> < 150 MHz.	—	$\pm 300$	—	$\pm 300$	—	$\pm 300$	—	$\pm 300$	ps	
CLKIN_CYC_JITT_FX_HF	Cycle-to-cycle jitter at the CLKIN input, based on CLKFX output frequency: F <sub>CLKFX</sub> > 150 MHz.	—	$\pm 150$	—	$\pm 150$	—	$\pm 150$	—	$\pm 150$	ps	
CLKIN_PER_JITT_FX	Period jitter at the CLKIN input.	—	$\pm 1$	—	$\pm 1$	—	$\pm 1$	—	$\pm 1$	ns	

**Notes:**

- DFS specifications apply when using either of the DFS outputs (CLKFX or CLKFX180).
- When using both DFS and DLL outputs on the same DCM, follow the more restrictive CLKIN\_FREQ\_DLL specifications in Table 53.
- The CLKIN\_DIVIDE\_BY\_2 attribute increases the effective input frequency range. When set to TRUE, the input clock frequency is divided by two as it enters the DCM. Input clock frequencies for the clock buffer being used can be increased up to the F<sub>MAX</sub> (see Table 48 and Table 49 for BUFG and BUFI02 limits).
- CLKIN input jitter beyond these limits can cause the DCM to lose LOCK.

Table 57: Switching Characteristics for the Digital Frequency Synthesizer DFS (DCM\_CLKGEN)<sup>(1)</sup>

Symbol	Description	Speed Grade								Units	
		-3		-3N		-2		-1L			
		Min	Max	Min	Max	Min	Max	Min	Max		
<b>Output Frequency Ranges (DCM_CLKGEN)</b>											
CLKOUT_FREQ_FX	Frequency for the CLKFX and CLKFX180 outputs	5	375	5	375	5	333	5	200	MHz	
CLKOUT_FREQ_FXDV	Frequency for the CLKFXDV output	0.15625	187.5	0.15625	187.5	0.15625	166.5	0.15625	100	MHz	
<b>Output Clock Jitter<sup>(2)(3)</sup></b>											
CLKOUT_PER_JITT_FX	Period jitter at the CLKFX and CLKFX180 outputs.	Typical = ±[0.2% of CLKFX period + 100]								ps	
CLKOUT_PER_JITT_FXDV	Period jitter at the CLKFXDV output.	Typical = ±[0.2% of CLKFX period + 100]								ps	
CLKFX_FREEZE_VAR	CLKFX period change in free running oscillator mode at the same temperature. FCLKFX > 50 MHz	Maximum = ±3% of CLKFX period								ps	
	CLKFX period change in free running oscillator mode at the same temperature. FCLKFX < 50 MHz	Maximum = ±5% of CLKFX period								ps	
CLKFX_FREEZE_TEMP_SLOPE	CLKFX period will change in free oscillator mode over temperature. Add to CLKFX_FREEZE_VAR to determine total CLKFX period change. Percentage change for CLKFX period over 1°C.	Maximum = 0.1								%/°C	
<b>Duty Cycle<sup>(4)(5)</sup></b>											
CLKOUT_DUTY_CYCLE_FX	Duty cycle precision for the CLKFX and CLKFX180 outputs, including the BUFGMUX and clock tree duty-cycle distortion	Maximum = ±[1% of CLKFX period + 350]								ps	
CLKOUT_DUTY_CYCLE_FXDV	Duty cycle precision for the CLKFXDV outputs, including the BUFGMUX and clock tree duty-cycle distortion	Maximum = ±[1% of CLKFX period + 350]								ps	
<b>Lock Time</b>											
LOCK_FX <sup>(2)</sup>	The time from deassertion at the DCM's Reset input to the rising transition at its LOCKED output. The DFS asserts LOCKED when the CLKFX, CLKFX180, and CLKFXDV signals are valid. Lock time requires CLKFX_DIVIDE < $F_{IN}/(0.50 \text{ MHz})$ when: $F_{CLKIN} < 50 \text{ MHz}$	–	50	–	50	–	50	–	50	ms	
	when: $F_{CLKIN} > 50 \text{ MHz}$	–	5	–	5	–	5	–	5	ms	

Table 65: Global Clock Input to Output Delay With DCM in Source-Synchronous Mode

Symbol	Description	Device	Speed Grade				Units
			-3	-3N	-2	-1L	
LVCMOS25 Global Clock Input to Output Delay using Output Flip-Flop, 12mA, Fast Slew Rate, <i>with</i> DCM in Source-Synchronous Mode.							
T <sub>CLOCKOFDCM_0</sub>	Global Clock and OUTFF <i>with</i> DCM	XC6SLX4	5.03	N/A	7.21	8.05	ns
		XC6SLX9	5.03	6.13	7.21	8.05	ns
		XC6SLX16	5.08	5.51	6.44	7.96	ns
		XC6SLX25	4.81	5.13	5.69	7.94	ns
		XC6SLX25T	4.81	5.13	5.69	N/A	ns
		XC6SLX45	5.26	5.69	6.63	7.92	ns
		XC6SLX45T	5.26	5.69	6.63	N/A	ns
		XC6SLX75	4.77	5.18	5.88	7.95	ns
		XC6SLX75T	4.77	5.18	5.88	N/A	ns
		XC6SLX100	4.72	5.11	5.76	8.59	ns
		XC6SLX100T	4.76	5.11	5.76	N/A	ns
		XC6SLX150	4.90	5.30	5.93	7.93	ns
		XC6SLX150T	4.90	5.30	5.93	N/A	ns
		XA6SLX4	5.35	N/A	7.21	N/A	ns
		XA6SLX9	5.35	N/A	7.21	N/A	ns
		XA6SLX16	5.42	N/A	6.44	N/A	ns
		XA6SLX25	5.13	N/A	5.69	N/A	ns
		XA6SLX25T	5.13	N/A	5.79	N/A	ns
		XA6SLX45	5.58	N/A	6.63	N/A	ns
		XA6SLX45T	5.58	N/A	6.63	N/A	ns
		XA6SLX75	5.09	N/A	5.87	N/A	ns
		XA6SLX75T	5.09	N/A	5.87	N/A	ns
		XA6SLX100	N/A	N/A	6.44	N/A	ns
		XQ6SLX75	N/A	N/A	5.87	7.95	ns
		XQ6SLX75T	5.09	N/A	5.87	N/A	ns
		XQ6SLX150	N/A	N/A	6.06	7.93	ns
		XQ6SLX150T	5.50	N/A	6.06	N/A	ns

**Notes:**

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. DCM output jitter is already included in the timing calculation.

## Source-Synchronous Switching Characteristics

The parameters in this section provide the necessary values for calculating timing budgets for Spartan-6 FPGA source-synchronous transmitter and receiver data-valid windows.

**Table 78: Duty Cycle Distortion and Clock-Tree Skew**

Symbol	Description	Device <sup>(1)</sup>	Speed Grade				Units
			-3	-3N	-2	-1L	
$T_{DCD\_CLK}$	Global Clock Tree Duty Cycle Distortion <sup>(2)</sup>	LX4	0.20	N/A	0.20	0.35	ns
		LX9	0.20	0.20	0.20	0.35	ns
		LX16	0.20	0.20	0.20	0.35	ns
		LX25	0.20	0.20	0.20	0.35	ns
		LX25T	0.20	0.20	0.20	N/A	ns
		LX45	0.20	0.20	0.20	0.35	ns
		LX45T	0.20	0.20	0.20	N/A	ns
		LX75	0.20	0.20	0.20	0.35	ns
		LX75T	0.20	0.20	0.20	N/A	ns
		LX100	0.20	0.20	0.20	0.35	ns
		LX100T	0.20	0.20	0.20	N/A	ns
		LX150	0.35	0.35	0.35	0.35	ns
		LX150T	0.35	0.35	0.35	N/A	ns
$T_{CKSKEW}$	Global Clock Tree Skew <sup>(3)</sup>	LX4	0.25	N/A	0.25	0.29	ns
		LX9	0.25	0.25	0.25	0.29	ns
		LX16	0.15	0.15	0.15	0.22	ns
		LX25	0.26	0.26	0.26	0.41	ns
		LX25T	0.26	0.26	0.26	N/A	ns
		LX45	0.20	0.20	0.20	0.28	ns
		LX45T	0.20	0.20	0.20	N/A	ns
		LX75	0.56	0.56	0.56	0.50	ns
		LX75T	0.56	0.56	0.56	N/A	ns
		XC6SLX100 <sup>(4)</sup>	0.22	0.22	0.22	0.21	ns
		XA6SLX100 <sup>(4)</sup>	N/A	N/A	0.43	N/A	ns
		LX100T	0.22	0.22	0.22	N/A	ns
		LX150	0.48	0.48	0.48	0.35	ns
		LX150T	0.48	0.48	0.48	N/A	ns
$T_{DCD\_BUFIO2}$	I/O clock tree duty cycle distortion	LX devices	0.25	0.25	0.25	0.50	ns
		LXT devices	0.25	0.25	0.25	N/A	ns

Table 78: Duty Cycle Distortion and Clock-Tree Skew (Cont'd)

Symbol	Description	Device <sup>(1)</sup>	Speed Grade				Units
			-3	-3N	-2	-1L	
$T_{BUFIOSKEW}$	I/O clock tree skew across one clock region	LX4	0.06	N/A	0.06	0.07	ns
		LX9	0.06	0.06	0.06	0.07	ns
		LX16	0.06	0.06	0.06	0.07	ns
		LX25	0.06	0.06	0.06	0.07	ns
		LX25T	0.06	0.06	0.06	N/A	ns
		LX45	0.06	0.06	0.06	0.07	ns
		LX45T	0.06	0.06	0.06	N/A	ns
		LX75	0.06	0.06	0.06	0.07	ns
		LX75T	0.06	0.06	0.06	N/A	ns
		LX100	0.06	0.06	0.06	0.07	ns
		LX100T	0.06	0.06	0.06	N/A	ns
		LX150	0.06	0.06	0.06	0.07	ns
		LX150T	0.06	0.06	0.06	N/A	ns

**Notes:**

1. LXT devices are not available with a -1L speed grade. The LX4 is not available in -3N speed grade.
2. These parameters represent the worst-case duty cycle distortion observable at the pins of the device using LVDS output buffers. For cases where other I/O standards are used, IBIS can be used to calculate any additional duty cycle distortion that might be caused by asymmetrical rise/fall times.
3. The  $T_{CKSKEW}$  value represents the worst-case clock-tree skew observable between sequential I/O elements. Significantly less clock-tree skew exists for I/O registers that are close to each other and fed by the same or adjacent clock-tree branches. Use the Xilinx FPGA Editor and Timing Analyzer tools to evaluate clock skew specific to your application.
4. The  $T_{CKSKEW}$  is 0.43 ns for the XA6SLX100 device using a -2 speed grade and 0.22 ns for the XC6SLX100 devices using the -2 speed grade.

Table 79: Package Skew

Symbol	Description	Device	Package <sup>(2)</sup>	Value	Units
$T_{PKGSKEW}$	Package Skew <sup>(1)</sup>	LX4	TQG144	N/A	ps
			CPG196	23	ps
			CSG225	58	ps
		LX9	TQG144	N/A	ps
			CPG196	23	ps
			CSG225	58	ps
			FT(G)256	88	ps
			CSG324	64	ps
		LX16	CPG196	19	ps
			CSG225	70	ps
			FT(G)256	71	ps
			CSG324	54	ps
		LX25	FT(G)256	90	ps
			CSG324	61	ps
			FG(G)484	84	ps
		LX25T	CSG324	48	ps
			FG(G)484	112	ps

Date	Version	Description of Revisions
06/14/10	1.5	<p>In <a href="#">Table 2</a>, added note 5 and added temperature range to <math>V_{FS}</math> and <math>R_{FUSE}</math>. Removed speed grade delineation, revised <math>I_{RPD}</math> description, and updated note 2 in <a href="#">Table 4</a>. Added note 2 to <a href="#">Table 7</a>. Added DIFF_MOBILE_DDR to <a href="#">Table 8</a> and <a href="#">Table 10</a>. Added note 4 to <a href="#">Table 15</a>. Changed minimum <math>DV_{PPIN}</math> in <a href="#">Table 16</a>. Updated <math>F_{GTPDRPCLK}</math> in <a href="#">Table 19</a>. Increased maximum <math>T_{LLSKEW}</math> in <a href="#">Table 22</a>. Updated descriptions and added data to <a href="#">Table 23</a>. Removed note 1 and added new data to the Networking Applications section in <a href="#">Table 25</a>. Updated <a href="#">Table 26</a> and <a href="#">Table 27</a> to the data in ISE v12.1 software with speed specification v1.08. In <a href="#">Table 28</a>, added DIFF_MOBILE_DDR and updated -4 speed grade data. Updated the maximum I/O pairs per bank in <a href="#">Table 33</a>. Updated note 2 on <a href="#">Table 39</a>. Revised the <math>F_{MAX}</math> in <a href="#">Table 44</a>. In <a href="#">Table 47</a>, updated description for <math>T_{SMCKCSO}</math>, revised values for <math>T_{POR}</math> and added Min value, added <math>T_{BPICCK}</math> and <math>T_{SPIICCK}</math>. Also in <a href="#">Table 47</a>, added device dependencies to <math>F_{SMCCK}</math> and <math>F_{RBCCCK}</math>. Updated and added data to <a href="#">Table 63</a> through <a href="#">Table 78</a>, and <a href="#">Table 81</a>. In <a href="#">Table 79</a>, added data on the XC6SLX45-FG(G)676 and revised the XC6SLX45T and XC6SLX150T values.</p> <p>The following changes to this specification are addressed in the product change notice <a href="#">XCN10024</a>, <i>MCB Performance and JTAG Revision Code for Spartan-6 LX16 and LX45 FPGAs</i>.</p> <p>In <a href="#">Table 2</a>, revised the <math>V_{CCINT}</math> to add the memory controller block extended performance specifications. In <a href="#">Table 25</a>, changed the standard specifications and added extended performance specifications for the memory controller block and note 2. Added note 4 and updated values in <a href="#">Table 34</a>.</p>
06/24/10	1.6	<p>Production release of XC6SLX45T (-2 and -3 speed grades), XC6SLX16 and XC6SLX45 (-3 speed grade) devices which includes changes to <a href="#">Table 26</a> and <a href="#">Table 27</a> (ISE v12.1 software with speed specification v1.08).</p> <p>Added the -3N speed grade, which designates Spartan-6 devices that do not support MCB functionality. This includes changes to <a href="#">Table 2</a> (note 2), <a href="#">Table 25</a> (note 4), and <a href="#">Switching Characteristics (Table 26)</a>.</p> <p>Updated <a href="#">Simultaneously Switching Outputs</a> discussion. Added -3 speed grade values for <math>T_{TAP}</math> and <math>F_{MINCAL}</math> values in <a href="#">Table 39</a>. In <a href="#">Table 40</a>, updated <math>T_{RPW}</math> (-2 and -3 speed grade) values and <math>F_{TOG}</math> (-3 speed grade) values. In <a href="#">Table 48</a>, updated <math>T_{GIO}</math> (-2 and -3 speed grade) values. Updated -3 values in spread spectrum section of <a href="#">Table 57</a>.</p>
07/16/10	1.7	<p>Production release of specific devices listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v12.2 software with speed specification v1.11. Added note 4 advising designers of the patch which contains v1.11. Also updated the -1L speed specification to v1.04. Updated numerous -4 and -1L values. Added -4 <math>T_{TAP}</math> values and <math>F_{MINCAL}</math> to <a href="#">Table 39</a>. Revised <math>T_{CINCK}/T_{CKCIN}</math> in <a href="#">Table 40</a>. In <a href="#">Table 41</a>, revised <math>T_{SHCKO}</math>. In <a href="#">Table 42</a>, revised <math>T_{REG}</math>. Added new -1L values to <a href="#">Table 47</a>. Added and updated values in <a href="#">Table 79</a>.</p>
07/26/10	1.8	<p>Production release of XC6SLX25, XC6SLX25T, XC6SLX100 and XC6SLX100T in the specific speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v12.2 software with speed specification v1.11. Added note 7 to <a href="#">Table 2</a> and moved <math>V_{FS}</math> and <math>R_{FUSE}</math> to a new <a href="#">Table 3</a>. Added <math>I_{HS}</math> and note 4 to <a href="#">Table 4</a>. Added note 1 to <a href="#">Table 28</a>. Added and updated SSO limits per <math>V_{CCO}/GND</math> pairs in <a href="#">Table 34</a>. Added note 3 to <a href="#">Table 47</a>. In <a href="#">Table 54</a>, removed -1L specifications for CLKOUT_PER_JITT_DV1/2 and revised CLKIN_CLKFB_PHASE and CLKOUT_PHASE_DLL values. Updated note 3 in both <a href="#">Table 56</a> and <a href="#">Table 57</a>.</p>
08/23/10	1.9	<p>Updated values for <math>F_{GTPRANGE1}</math>, <math>F_{GTPRANGE2}</math>, and <math>F_{GPLLMIN}</math> in <a href="#">Table 18</a>. Revised -3 and -4 values in <a href="#">Table 21</a>. Removed the -1L speed grade readback support restriction and note 3 in <a href="#">Table 47</a>.</p>
11/05/10	1.10	<p>Production release of XC6SLX4 and XC6SLX9 in the specific speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v12.3 software with speed specification v1.12 for the -2 speed grade available in the 12.3 Speed Files Patch. Added note 3 advising designers of the patch which contains v1.12.</p> <p>In <a href="#">Table 2</a>, added note 4. In <a href="#">Table 4</a>, added note 2. In <a href="#">Table 10</a>, added notes 2 and 3. In <a href="#">Table 44</a>, added note 2. In <a href="#">Table 47</a>, updated symbol for <math>T_{SMWCCK}/T_{SMCCCK}</math>, changed -1L values for <math>T_{USERCCLKH}</math> and <math>T_{USERCCLKL}</math>, and added and revised the modes for <math>F_{MCCK}</math> and <math>F_{SMCCK}</math>. In <a href="#">Table 53</a>, redefined and expanded description for CLKIN_FREQ_DLL and rewrote note 3. Updated title of <a href="#">Table 58</a>. Also in <a href="#">Table 78</a>, revised <math>T_{DCD\_CLK}</math> for XC6SLX150 and XC6SLX150T. Changed description of <math>T_{PSFD}/T_{PHFD}</math> in <a href="#">Table 71</a>.</p> <p>For the -1L speed grade, updated data sheet to ISE 12.3 software with speed specification v1.05 which revised the values in the following tables: <a href="#">Table 25</a>, <a href="#">Table 28</a>, <a href="#">Table 35</a>, <a href="#">Table 36</a>, <a href="#">Table 37</a>, <a href="#">Table 40</a> through <a href="#">Table 43</a>, <a href="#">Table 48</a> through <a href="#">Table 56</a>, <a href="#">Table 62</a> through <a href="#">Table 78</a>, <a href="#">Table 80</a>, and <a href="#">Table 81</a>.</p> <p>Updated <a href="#">Notice of Disclaimer</a>.</p>

Date	Version	Description of Revisions
01/10/11	1.11	<p>Production release of XC6SLX4 and XC6SLX9 in the specific speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v12.4 software with speed specification v1.15 for the -4, -3, -3N, and -2 speed grades. Added note 3 to <a href="#">Table 27</a>. Also updated the -1L speed grade requirements to ISE v12.4 software with speed specification v1.06. Revised -3N definition throughout the document.</p> <p>Added note 4 to <a href="#">Table 2</a> and updated note 5. Added information on <math>V_{CCINT}</math> to note 1 in <a href="#">Table 5</a>. Updated Networking Applications -3 values in <a href="#">Table 25</a> to match improvements made in ISE v12.4. In <a href="#">Table 28</a>, added note 1 and revised the <math>T_{IOTP}</math> values for LVDS_33, LVDS_25, MINI_LVDS_33, MINI_LVDS_25, RSDS_33, RSDS_25, TMDS_33, PPDS_33, and PPDS_25. Added note 3 to <a href="#">Table 55</a>.</p>
02/11/11	1.12	<p>As described in <a href="#">XCN11008: Product Discontinuation Notice For Spartan-6 LXT -4 Devices</a>, the -4 speed specifications have been discontinued. As outlined in page 2 of the XCN, designers currently using -4 speed specifications should rerun timing analysis using the new -3 speed specifications before moving to a replacement device.</p> <p>Updated the networking applications section of <a href="#">Table 25</a>. Updated -2 speed specifications throughout document and added note 3 to <a href="#">Table 27</a> advising designers to use the -2 speed specification update (v1.17) with the ISE 12.4 software patch. Added <math>F_{CLKDIV}</math> to <a href="#">Table 37</a> and <a href="#">Table 38</a>. Updated note 2 in <a href="#">Table 39</a>. Updated units for <math>T_{SMCKCSO}</math> and <math>T_{BPICCO}</math> in <a href="#">Table 47</a>. Updated -1L in <a href="#">Table 71</a>. Removed Note 2: <i>Package delay information is available for these device/package combinations. This information can be used to deskew the package from Table 79.</i></p>
03/31/11	2.0	<p>Production release of XC6SLX45 in the -1L speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.1 software with -1L speed specification v1.06.</p> <p>In <a href="#">Table 39</a>, removed values in the -1L column and added note 3 as IODELAY2 only supports Tap0 for lower-power devices. Updated copyright <a href="#">page 1</a> and <a href="#">Notice of Disclaimer</a>.</p>
05/20/11	2.1	<p>Production release of XC6SLX100 and XC6SLX150 in the specific speed grades listed in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.1 software with -1L speed specification v1.06. Updated <a href="#">Table 27</a> and <a href="#">Note 7</a> with changes per <a href="#">XCN11012: Speed File Change for -3N Devices</a>. Revised <a href="#">Switching Characteristics</a> section for speed specifications: v1.18 for -3, -3N, and -2; including improvements in <a href="#">Table 73</a> through <a href="#">Table 77</a> and <a href="#">Table 81</a>.</p> <p>Removed <i>Memory Controller Block</i> from the performance heading in <a href="#">Table 2</a> and revised <a href="#">Note 2</a>. In <a href="#">Table 4</a>, added <a href="#">Note 1</a> to <math>C_{IN}</math> and updated the description of <math>R_{IN\_TERM}</math>. Updated <a href="#">Note 1</a> in <a href="#">Table 5</a>. Updated <a href="#">Note 1</a> of <a href="#">Table 7</a>. In <a href="#">Table 25</a>, added and removed -1L specifications, increased the standard performance DDR3 specifications, removed the extended performance DDR3 row and updated <a href="#">Note 3</a> and <a href="#">Note 4</a>. Clarified the introductory information for <a href="#">Table 28</a> and <a href="#">Table 30</a>.</p> <p>In <a href="#">Table 32</a>: Revised <math>V_{MEAS}</math> value for LVCMOS12; revised <math>V_{REF}</math> for LVDS_25, LVDS_33, BLVDS_25, MINI_LVDS_25, MINI_LVDS_33, RSDS_25, and RSDS_33; revised <math>R_{REF}</math> for BLVDS_25 and TMDS_33; and added <a href="#">Note 4</a> and <a href="#">Note 5</a>. Updated <a href="#">Note 2</a> and <a href="#">Note 3</a> in <a href="#">Table 39</a>.</p> <p>In <a href="#">Table 47</a>, revised the values and description of <math>T_{POR}</math> including adding <a href="#">Note 3</a>. Also in <a href="#">Table 47</a>, augmented the description and added specifications for <math>F_{RBCK}</math> and removed XC6SLX4 from <math>F_{MCCK}</math> (maximum frequency, parallel mode (Master SelectMAP/BPI)). Added BUFGMUX to <a href="#">Table 48</a> title. Added <a href="#">Table 50</a>.</p> <p>In <a href="#">Table 52</a>, revised specifications for <math>T_{EXTFDVAR}</math> and <math>F_{INJITTER}</math>. In <a href="#">Table 54</a> removed the 5 MHz &lt; <math>CLKIN\_FREQ\_DLL</math> parameter in the <math>LOCK\_DLL</math> description. In both <a href="#">Table 56</a> and <a href="#">Table 57</a>, removed the 5 MHz &lt; <math>F_{CLKIN}</math> parameter in the <math>LOCK\_FX</math> description. In <a href="#">Table 58</a>, updated description for <math>PSCLK\_FREQ</math> and <math>PSCLK\_PULSE</math>.</p> <p>Revised title and symbol of <a href="#">Table 70</a>, added new speed specifications for -1L, and added <a href="#">Note 2</a>. Added <a href="#">Table 71</a>.</p>
07/11/11	2.2	<p>Added the Automotive XA Spartan-6 and Defense-grade Spartan-6Q devices to all appropriate tables while sometimes removing the XC6S nomenclature. Added expanded temperature range (Q) to all appropriate tables. Updated <math>T_{SOL}</math> packages in <a href="#">Table 1</a>. Added <math>R_{OUT\_TERM}</math> to <a href="#">Table 4</a>. Updated <a href="#">Note 2</a> on <a href="#">Table 13</a>.</p> <p>Production release of the XC6SLX4, XC6SLX9, XC6SLX16, XC6SLX25, XC6SLX75, XQ6SLX75, and XQ6SLX150 in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.2 software with -1L speed specification v1.07.</p> <p>Production release of the XA6SLX16, XA6SLX25T, XA6SLX45, XA6SLX45T, XQ6SLX75, XQ6SLX75T, XQ6SLX150, and XQ6SLX150T in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.2 software with -2 and -3 speed specification v1.19.</p> <p>Added <a href="#">Table 29: IOB Switching Characteristics for the Automotive XA Spartan-6 and the Spartan-6Q Devices(1)</a>. Updated CS(G)484 from CSG484 throughout data sheet. Clarified <a href="#">Note 3</a> in <a href="#">Table 39</a>.</p>
08/08/11	2.3	Production release of the XA6SLX25, XA6SLX75, and XA6SLX75T in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.2 software with -2 and -3 speed specification v1.19.

Date	Version	Description of Revisions
09/14/11	2.4	<p>Production release of the XA6SLX4 and XA6SLX9 devices in <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.2 software with -2 and -3 speed specification v1.19. Added production released version of the XA6SLX100 to <a href="#">Table 26</a> and <a href="#">Table 27</a> using ISE v13.3 software with -2 speed specification v1.20.</p> <p>Updated <math>R_{OUT\_TERM}</math> description in <a href="#">Table 4</a>. Fixed the LVPECL <math>V_H</math> error in <a href="#">Table 31</a>. Updated introduction in <a href="#">Simultaneously Switching Outputs</a>. Added the XA6SLX100 to <a href="#">Table 63</a> through <a href="#">Table 78</a>, and <a href="#">Table 81</a>. Added <a href="#">Note 4</a> to <a href="#">Table 78</a> because the <math>T_{CKSKEW}</math> for the XC6SLX100 is not the same as the <math>T_{CKSKEW}</math> for the XA6SLX100.</p> <p>Revised the revision history for version <a href="#">1.6</a> dated <a href="#">06/24/10</a>. Removed the parenthetical statement about the -3N speed grade: (specifications are identical to the -3 speed grade).</p>
10/17/11	3.0	<p>Changed the data sheet from Preliminary Product Specification to Product Specification.</p> <p>Updated the <a href="#">Switching Characteristics, page 19</a> speed specification version ISE v13.3 software to -2 and -3 speed specification v1.20 and -1L speed specification of v1.08. Also updated <a href="#">Note 1</a> in <a href="#">Table 27</a>.</p> <p>In <a href="#">Table 43, Block RAM Switching Characteristics</a>, the <math>F_{MAX}</math> value for the -2 speed grade has been changed from 260 MHz to 280 MHz.</p> <p>In <a href="#">Table 54, Switching Characteristics for the DLL</a>, a <a href="#">Note 6</a> was added and linked to CLKIN_CLKFB_PHASE.</p>